











CSD16321Q5

SLPS220D - AUGUST 2009 - REVISED MAY 2017

# CSD16321Q5 25-V N-Channel NexFET™ Power MOSFET

#### **Features**

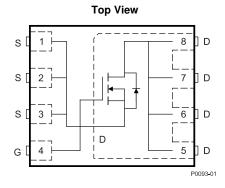
- Optimized for 5-V Gate Drive
- Ultra-Low Q<sub>q</sub> and Q<sub>qd</sub>
- Low-Thermal Resistance
- Avalanche Rated
- Lead-Free Terminal Plating
- **RoHS Compliant**
- SON 5-mm × 6-mm Plastic Package

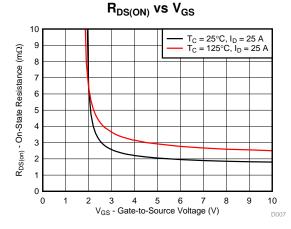
## 2 Applications

- Point-of-Load Synchronous Buck Converter for Applications in Networking, Telecom, and Computing Systems
- Optimized for Synchronous FET Applications

### 3 Description

This 25-V, 1.9-m $\Omega$ , 5-mm × 6-mm SON NexFET<sup>TM</sup> power MOSFET has been designed to minimize losses in power conversion and optimized for 5-V gate drive applications.





#### **Product Summary**

T <sub>A</sub> = 25°	С	TYPICAL VA	UNIT	
$V_{DS}$	Drain-to-Source Voltage	25		٧
$Q_g$	Gate Charge Total (4.5 V)	14		nC
$Q_{gd}$	Gate Charge Gate-to-Drain 2.5			
		$V_{GS} = 3 V$	2.8	
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 4.5 V	2.1	mΩ
		V <sub>GS</sub> = 8 V 1.9		
V <sub>GS(th)</sub>	Threshold Voltage	1.1	٧	

### **Device Information**(1)

DEVICE	MEDIA	QTY	PACKAGE	SHIP
CSD16321Q5	13-Inch Reel	2500	SON	Tape
CSD16321Q5T	7-Inch Reel	250	5.00-mm × 6.00-mm Plastic Package	and Reel

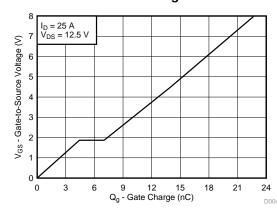
(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### **Absolute Maximum Ratings**

T <sub>A</sub> = 2	5°C	VALUE	UNIT	
$V_{DS}$	Drain-to-Source Voltage	25	٧	
$V_{\text{GS}}$	Gate-to-Source Voltage	+10 / -8	٧	
	Continuous Drain Current (Package Limited)	100		
I <sub>D</sub>	Continuous Drain Current (Silicon Limited), $T_C = 25^{\circ}C$	177	Α	
	Continuous Drain Current <sup>(1)</sup>	29	1	
I <sub>DM</sub>	Pulsed Drain Current <sup>(2)</sup>	400	Α	
D	Power Dissipation <sup>(1)</sup>	3.1	W	
$P_D$	Power Dissipation, T <sub>C</sub> = 25°C	113	VV	
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction, Storage Temperature	-55 to 150	°C	
E <sub>AS</sub>	Avalanche Energy, Single Pulse $I_D$ = 66 A, L = 0.1 mH, $R_G$ = 25 $\Omega$	218	mJ	

- (1) Typical  $R_{\theta JA} = 40 ^{\circ} C/W$  on 1-in<sup>2</sup>, 2-oz Cu pad on 0.06-in thick FR4 PCB.
- (2) Max  $R_{\theta JC} = 1.1$  °C/W, pulse duration  $\leq 100$  µs, duty cycle  $\leq$

#### **Gate Charge**





## **Table of Contents**

1       Features       1         2       Applications       1         3       Description       1         4       Revision History       2         5       Specifications       3         5.1       Electrical Characteristics       3         5.2       Thermal Information       3         5.3       Typical MOSFET Characteristics       4         6       Device and Documentation Support       7	6.1 Receiving Notification of Documentation Updates 6.2 Community Resources
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# 4 Revision History

NC	OTE: Page numbers for previous revisions may differ from page numbers in the current version.	
Cł	anges from Revision C (December 2016) to Revision D	е
•	Changed the R <sub>DS(ON)</sub> values at 3 V, 4.5 V, 8 V & the <i>Description</i> to match the values on the <i>Electrical Characteristics</i> table.	1
Cł	anges from Revision B (May 2010) to Revision C Pag	е
•	Changed Description text	1
•	Added silicon limited continuous drain current to Absolute Maximum Ratings table	1
•	Added max power dissipation at T <sub>C</sub> = 25°C to <i>Absolute Maximum Ratings</i> table	1
•	Changed Note 2 in Absolute Maximum Ratings table	
•	Changed R <sub>BJA</sub> max from 48°C/W: to 50°C/W	3
•	Changed the SOA in Figure 10 to reflect measured data	6
•	Added Device and Documentation Support section	7
<u>.</u>	Changed MECHANICAL DATA section to Mechanical, Packaging, and Orderable Information section	8
Cł	anges from Revision A (Jaunary 2010) to Revision B	е
•	Changed R <sub>DS(on)</sub> - V <sub>GS</sub> = 3 V, I <sub>D</sub> = 25 A MAX value From: 3.5 To: 3.8	3
<u>.</u>	Deleted the Package Marking Information section	
Cł	ranges from Original (August 2009) to Revision A Pag	е
•	Changed the labels on the Top View pinout image	1
•	Changed Note 1 of the From: R <sub>0JA</sub> = 39°C/W To: Typical R <sub>0JA</sub> = 39°C/W	1
•	Changed Figure 1 text From: R <sub>θJA</sub> = 92°C/W To: Typical R <sub>θJA</sub> = 93°C/W	4
•	Changed Figure 10 text From: R <sub>θJA</sub> = 92°C/W To: Typical R <sub>θJA</sub> = 93°C/W	
•	Changed Figure 11 X-axis values	5



## 5 Specifications

#### 5.1 Electrical Characteristics

 $T_A = 25^{\circ}C$  (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV <sub>DSS</sub>	Drain-to-source voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
I <sub>DSS</sub>	Drain-to-source leakage current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V			1	μА
I <sub>GSS</sub>	Gate-to-source leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = +10 / -8 \text{ V}$			100	nA
V <sub>GS(th)</sub>	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.9	1.1	1.4	V
		V <sub>GS</sub> = 3 V, I <sub>D</sub> = 25 A		2.8	3.8	
R <sub>DS(on)</sub>	Drain-to-source on resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 25 A		2.1	2.6	$m\Omega$
		$V_{GS} = 8 \text{ V}, I_D = 25 \text{ A}$		1.9	2.4	
9 <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 12.5 V, I <sub>D</sub> = 25 A		150		S
DYNAMI	C CHARACTERISTICS					
C <sub>iss</sub>	Input capacitance			2360	3100	pF
C <sub>oss</sub>	Output capacitance	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 12.5 V, f = 1 MHz		1700	2200	pF
C <sub>rss</sub>	Reverse transfer capacitance			115	150	pF
R <sub>G</sub>	Series gate resistance			1.5	3	Ω
Qg	Gate charge total (4.5 V)			14	19	nC
$Q_{gd}$	Gate charge gate-to-drain	V <sub>DS</sub> = 12.5 V, I <sub>D</sub> = 25 A		2.5		nC
$Q_{gs}$	Gate charge gate-to-source	V <sub>DS</sub> = 12.5 V, I <sub>D</sub> = 25 A		4		nC
$Q_{g(th)}$	Gate charge at V <sub>th</sub>			2.1		nC
Q <sub>oss</sub>	Output charge	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$		36		nC
t <sub>d(on)</sub>	Turnon delay time			9		ns
t <sub>r</sub>	Rise time	V <sub>DS</sub> = 12.5 V, V <sub>GS</sub> = 4.5 V,		15		ns
t <sub>d(off)</sub>	Turnoff delay time	$I_D = 25 \text{ A}, R_G = 2 \Omega$		27		ns
t <sub>f</sub>	Fall time			17		ns
DIODE C	CHARACTERISTICS					
$V_{SD}$	Diode forward voltage	I <sub>SD</sub> = 25 A, V <sub>GS</sub> = 0 V		0.8	1	V
Q <sub>rr</sub>	Reverse recovery charge	$V_{DD}$ = 13 V, $I_F$ = 25 A, di/dt = 300 A/ $\mu$ s		33		nC
t <sub>rr</sub>	Reverse recovery time	$V_{DD} = 13 \text{ V}, I_F = 25 \text{ A}, di/dt = 300 \text{ A}/\mu\text{s}$		32		ns

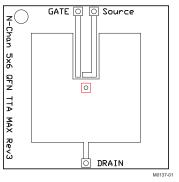
#### 5.2 Thermal Information

 $T_A = 25$ °C (unless otherwise stated)

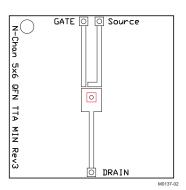
	PARAMETER	MIN	TYP	MAX	UNIT
R <sub>θJC</sub>	Junction-to-case thermal resistance <sup>(1)</sup>			1.1	°C/W
R <sub>θJA</sub>	Junction-to-ambient thermal resistance <sup>(1)</sup> (2)			50	°C/W

<sup>(1)</sup>  $R_{\theta JC}$  is determined with the device mounted on a 1-in<sup>2</sup>, 2-oz Cu pad on a 1.5-in  $\times$  1.5-in, 0.06-in thick FR4 board.  $R_{\theta JC}$  is specified by design while  $R_{\theta JA}$  is determined by the user's board design. Device mounted on FR4 Material with 1 in² of 2-oz Cu.





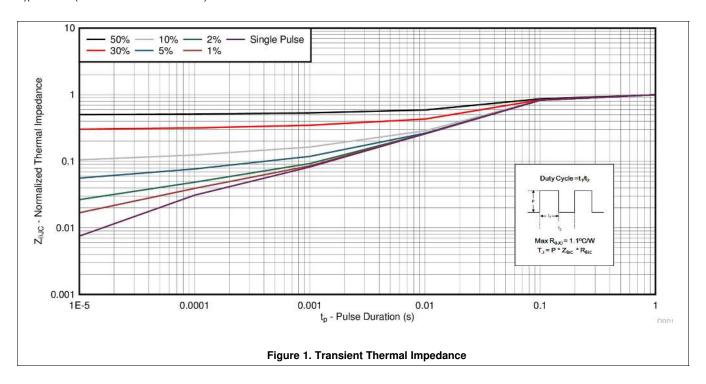
 $\label{eq:maxR} \begin{array}{l} \text{Max R}_{\theta JA} = 50^{\circ}\text{C/W} \\ \text{when mounted on 1 in}^2 \\ \text{of 2-oz Cu.} \end{array}$ 



Max  $R_{\theta JA} = 125^{\circ}C/W$  when mounted on minimum pad area of 2-oz Cu.

## 5.3 Typical MOSFET Characteristics

 $T_A = 25$ °C (unless otherwise stated)



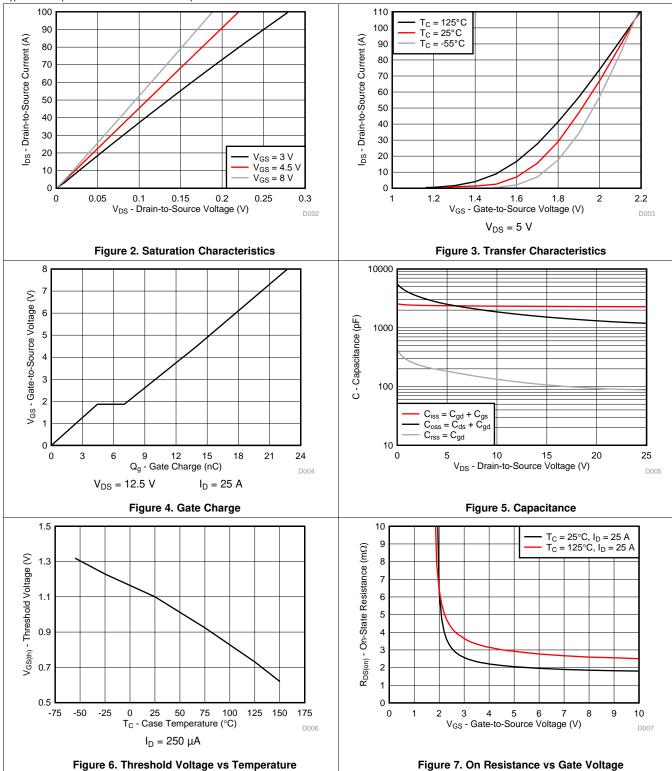
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### **Typical MOSFET Characteristics (continued)**

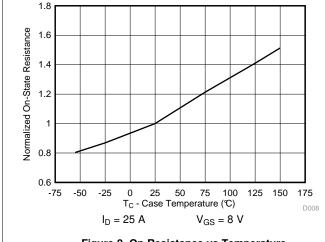
 $T_A = 25$ °C (unless otherwise stated)





### **Typical MOSFET Characteristics (continued)**

 $T_A = 25$ °C (unless otherwise stated)



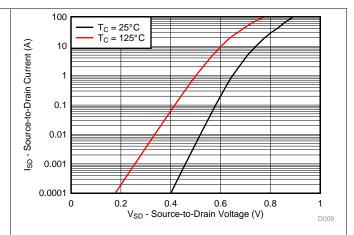
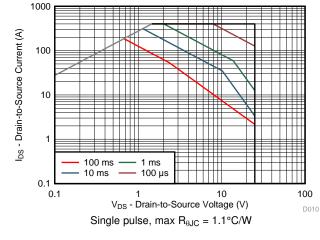


Figure 8. On Resistance vs Temperature

Figure 9. Typical Diode Forward Voltage



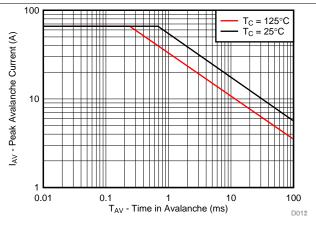


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

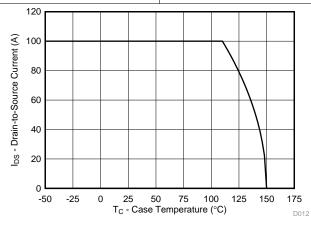


Figure 12. Maximum Drain Current vs Temperature

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### 6 Device and Documentation Support

#### 6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

#### 6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 6.5 Glossary

SLYZ022 — TI Glossary.

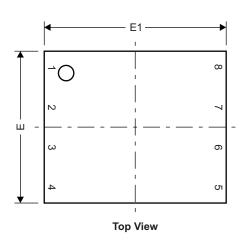
This glossary lists and explains terms, acronyms, and definitions.

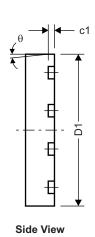


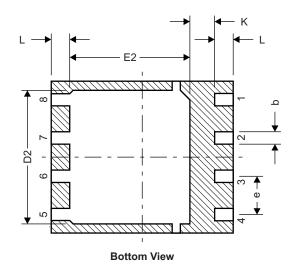
## 7 Mechanical, Packaging, and Orderable Information

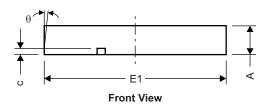
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## 7.1 Q5 Package Dimensions







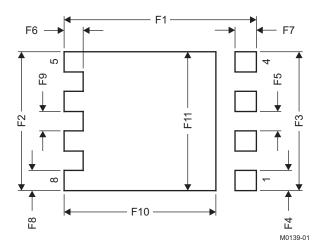


M0140-01

DIM	MILLIMETERS	S	INCHE	S
DIIVI	MIN	MAX	MIN	MAX
Α	0.950	1.050	0.037	0.039
b	0.360	0.460	0.014	0.018
С	0.150	0.250	0.006	0.010
c1	0.150	0.250	0.006	0.010
D1	4.900	5.100	0.193	0.201
D2	4.320	4.520	0.170	0.178
E	4.900	5.100	0.193	0.201
E1	5.900	6.100	0.232	0.240
E2	3.920	4.12	0.154	0.162
е	1.27 TYP		0.050 T	ΥP
K	0.760		0.030	
L	0.510	0.710	0.020	0.028
θ	0.00		_	



### 7.2 Recommended PCB Pattern

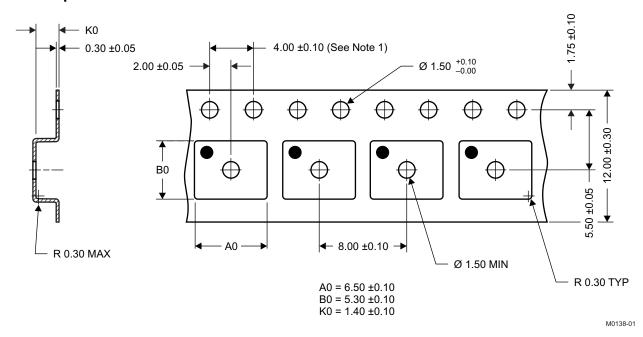


DIM	MILLIMETERS	INCHES			
DIIVI	MIN MAX	MIN MAX			
F1	6.205 6.305	0.244 0.248			
F2	4.460 4.560	0.176 0.180			
F3	4.460 4.560	0.176 0.180			
F4	0.650 0.700	0.026 0.028			
F5	0.620 0.670	0.024 0.026			
F6	0.630 0.680	0.025 0.027			
F7	0.700 0.800	0.028 0.031			
F8	0.650 0.700	0.026 0.028			
F9	0.620 0.670	0.024 0.026			
F10	4.900 5.000	0.193 0.197			
F11	4.460 4.560	0.176 0.180			

For recommended circuit layout for PCB designs, see *Reducing Ringing Through PCB Layout Techniques* (SLPA005).



#### 7.3 Q5 Tape and Reel Information



#### Notes:

- 1. 10-sprocket hole pitch cumulative tolerance ±0.2.
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm.
- 3. Material: black static dissipative polystyrene.
- 4. All dimensions are in mm (unless otherwise specified).
- 5. Thickness: 0.30 ±0.05 mm.
- 6. MSL1 260°C (IR and Convection) PbF Reflow Compatible.

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#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD16321Q5	ACTIVE	VSON-CLIP	DQH	8	2500	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD16321	Samples
CSD16321Q5T	ACTIVE	VSON-CLIP	DQH	8	250	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD16321	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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